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N-channel TrenchMOS standard level FET Rev. 02 — 21 April 2011

Product data sheet

1. **Product profile**

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- AEC Q101 compliant
- Suitable for standard level gate drive sources

1.3 Applications

- 12 V, 24 V and 42 V loads
- Automotive systems

- Suitable for thermally demanding environments due to 175 °C rating
- General purpose power switching
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1.	Quick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	75	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 4</u>	<u>[1][2]</u>	-	-	100	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	333	W
Static cha	aracteristics						
R _{DSon}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \text{ V}; \text{ I}_{D} = 25 \text{ A}; \\ T_{j} = 25 \text{ °C}; \text{ see } \underline{\text{Figure 7}}; \\ \text{see } \underline{\text{Figure 8}} \end{array}$		-	3.7	4.3	mΩ
Avalanch	e ruggedness						
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$ \begin{split} I_D &= 100 \text{ A}; \text{V}_{sup} \leq 75 \text{V}; \\ \text{R}_{GS} &= 50 \Omega; \text{V}_{GS} = 10 \text{V}; \\ \text{T}_{j(\text{init})} &= 25 ^\circ\text{C}; \text{ unclamped} \end{split} $		-	-	630	mJ

[1] Continuous current is limited by package.

[2] Refer to document 9397 750 12572 for further information.



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2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT78A (TO-220AB)

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK754R3-75C	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A

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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	75	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	75	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V}; \text{ see } \frac{\text{Figure 1}}{\text{Figure 1}};$	[1][2]	-	192	А
		see <u>Figure 4</u>	[3][2]	-	100	А
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 1</u> ; see <u>Figure 4</u>	<u>[3][2]</u>	-	100	A
I _{DM}	peak drain current	T _{mb} = 25 °C; pulsed; t _p ≤ 10 μs; see <u>Figure 4</u>		-	769	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	333	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	n diode					
Is	source current	T _{mb} = 25 °C	[2][3]	-	100	А
			[2][1]	-	192	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	769	А
Avalanche r	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	I_D = 100 A; $V_{sup} \le 75$ V; $R_{GS} = 50$ Ω; $V_{GS} = 10$ V; $T_{j(init)} = 25$ °C; unclamped		-	630	mJ
E _{DS(AL)R}	repetitive drain-source avalanche energy	see Figure 3	[4][5][6][7]	-	-	J

[1] Current is limited by power dissipation chip rating.

[2] Refer to document 9397 750 12572 for further information.

[3] Continuous current is limited by package.

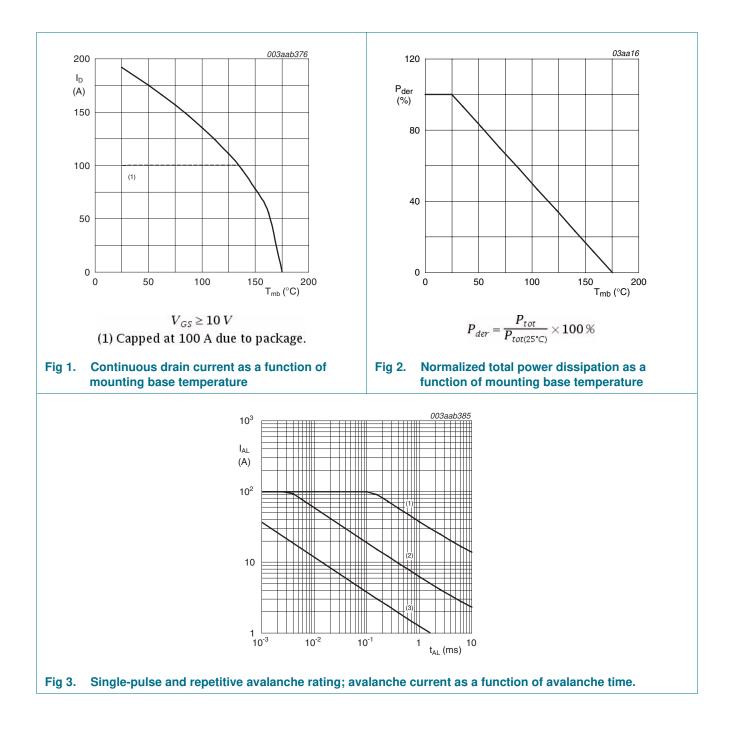
[4] Maximum value not quoted. Repetitive rating defined in avalanche rating figure.

[5] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

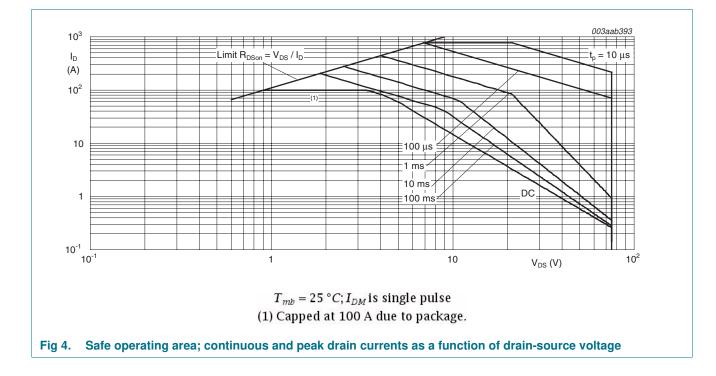
[6] Repetitive avalanche rating limited by an average junction temperature of 170 °C.

[7] Refer to application note AN10273 for further information.

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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base		-	-	0.45	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in free air	-	60	-	K/W

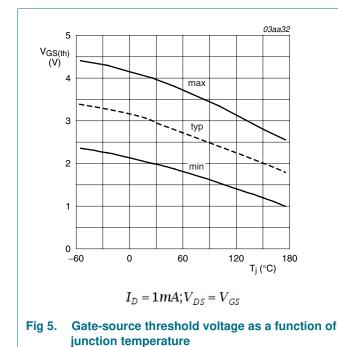
6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	octeristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	75	-	-	V
	voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	70	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 5</u> ; see <u>Figure 6</u>	-	-	4.4	V
V _{GSth}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 5</u> ; see <u>Figure 6</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 5</u> ; see <u>Figure 6</u>	2	3	4	V
I _{DSS}	drain leakage current	$V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μΑ
GSS	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	9	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	3.7	4.3	mΩ
IDSS	drain leakage current	$V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
Dynamic ch	aracteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 60 \text{ V}; V_{GS} = 10 \text{ V};$	-	142	-	nC
Q_{GS}	gate-source charge	see <u>Figure 9</u>	-	36	-	nC
Q _{GD}	gate-drain charge		-	67	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 60 \text{ V}; \text{ see } \frac{\text{Figure 9}}{\text{Figure 9}}$	-	5	-	V
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	8744	11659	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 10</u>	-	923	1108	pF
S _{rss}	reverse transfer capacitance		-	579	793	pF
d(on)	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	61	-	ns
r	rise time	$R_{G(ext)} = 10 \ \Omega$	-	100	-	ns
d(off)	turn-off delay time		-	194	-	ns
f	fall time		-	90	-	ns

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Table 6.	Characteristics continued					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
L _D	internal drain inductance	from drain lead 6mm from package to centre of die	-	4.5	-	nH
		from contact screw on mounting base to centre of die	-	3.5	-	nH
L _S	internal source inductance	from source lead to source bonding pad	-	7.5	-	nH
Source-d	rain diode					
V_{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 11</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s};$	-	83	-	ns
Q _r	recovered charge	$V_{GS} = 0 V; V_{DS} = 25 V$	-	155	-	nC



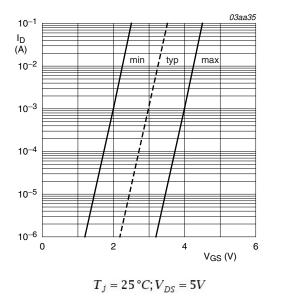
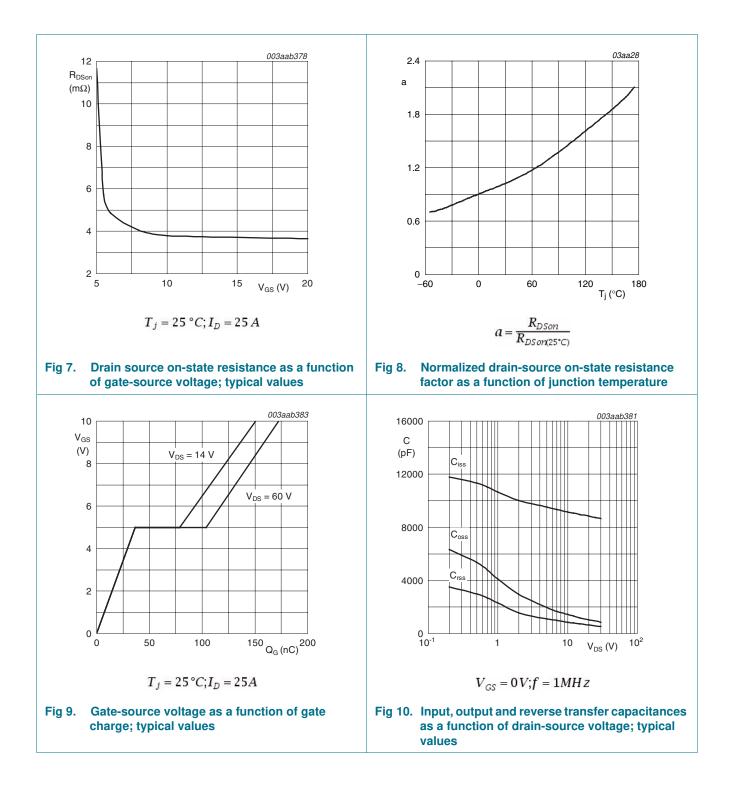


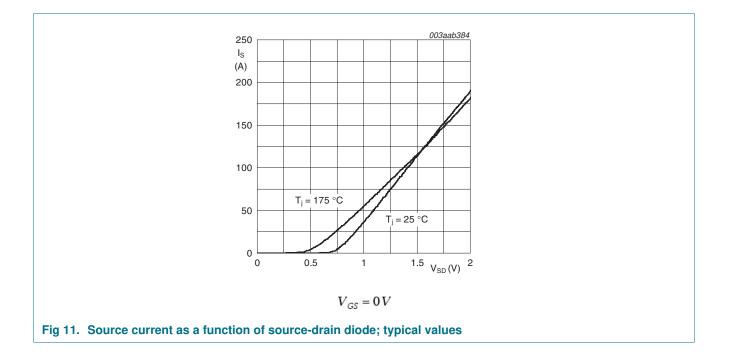
Fig 6. Sub-threshold drain current as a function of gate-source voltage

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7. Package outline

nm are 1	the origi	inal dime	ensions))	0 L	5 scal		0 mm J						
A1	b	b ₁	c	D	D ₁	E	е	L	L1 ⁽¹⁾	L ₂ max.	р	q	Q	
1.39		1.3	0.7	15.8	6.4	10.3	2.54	15.0	3.30	3.0	3.8	3.0	2.6	1
1.27	0.0	1.0	0.4	10.2	0.9	5.1		10.0	2.13		0.0	2.1	2.2	
nis zone	e are not t	tinned.												
				_							ELID4			
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	A₁ 1.39 1.27	A1 b 1.39 0.9 1.27 0.6	A1 b b1 1.39 0.9 1.3	A1 b b1 c 1.39 0.9 1.3 0.7 1.27 0.6 1.0 0.4	1.39 0.9 1.3 0.7 15.8 1.27 0.6 1.0 0.4 15.2	A1 b b1 c D D1 1.39 0.9 1.3 0.7 15.8 6.4 1.27 0.6 1.0 0.4 15.2 5.9	b b1 c D D1 E 1.39 0.9 1.3 0.7 15.8 6.4 10.3 1.27 0.6 1.0 0.4 15.2 5.9 9.7	A1 b b1 c D D1 E e 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54	b b1 c D D1 E e L 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 13.5	b b1 c D D1 E e L L1 ⁽¹⁾ 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 3.30 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 13.5 2.79	A1 b b1 c D D1 E e L L1 ⁽¹⁾ L2 max. 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 3.30 3.0 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 15.0 2.79 3.0	A1 b b1 c D D1 E e L L1 ⁽¹⁾ L2 max. p 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 3.30 3.0 3.8 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 13.5 2.79 3.0 3.8 s zone are not timed. Source are not timed. Source are not timed. Source are not timed. Source are not timed.	Mare the original dimensions: A1 b b1 c D D1 E e L L1 ⁽¹⁾ L2 p q 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 3.30 3.0 3.8 3.0 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 15.0 3.30 3.0 3.6 2.7	A1 b b1 c D D1 E e L L1 ⁽¹⁾ L2 max. p q Q 1.39 0.9 1.3 0.7 15.8 6.4 10.3 2.54 15.0 3.30 3.0 3.8 3.0 2.6 1.27 0.6 1.0 0.4 15.2 5.9 9.7 2.54 13.5 2.79 3.0 3.8 3.0 2.6 s zone are not timed.

Fig 12. Package outline SOT78A (TO-220AB)

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8. Revision history

Table 7. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK754R3-75C v.2	20110421	Product data sheet	-	BUK75_7E4R3-75C v.1
Modifications:	guidelines of l Legal texts ha 	this data sheet has been NXP Semiconductors. Ive been adapted to the ne BUK754R3-75C separate	ew company name wh	ere appropriate.
BUK75_7E4R3-75C v.1	20060810	Product data sheet	-	-

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9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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[2] The term 'short data sheet' is explained in section "Definitions".

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